

# Defect-induced magnetism in homoepitaxial SrTiO<sub>3</sub> <sup>EP</sup>

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## ABSTRACT

Along with recent advancements in thin-film technologies, the engineering of complex transition metal oxide heterostructures offers the possibility of creating novel and tunable multifunctionalities. A representative complex oxide is the perovskite strontium titanate (STO), whose bulk form is nominally a centrosymmetric paraelectric band insulator. By tuning the electron doping, chemical stoichiometry, strain, and charge defects of STO, it is possible to control the electrical, magnetic, and thermal properties of such structures. Here, we demonstrate tunable magnetism in atomically engineered STO thin films grown on STO (001) substrates by controlling the atomic charge defects of titanium ( $V_{\text{Ti}}$ ) and oxygen ( $V_{\text{O}}$ ) vacancies. Our results show that the magnetism can be tuned by altering the growth conditions. We provide deep insights into its association to the following defect types: (i)  $V_{\text{Ti}}$ , resulting in a charge rearrangement and local spin polarization, (ii)  $V_{\text{O}}$ , leading to weak magnetization, and (iii)  $V_{\text{Ti}}-V_{\text{O}}$  pairs, which lead to the appearance of a sizable magnetic signal. Our results suggest that controlling charged defects is critical for inducing a net magnetization in STO films. This work provides a crucial step for designing magnetic STO films via defect engineering for magnetic and spin-based electronic applications.

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## INTRODUCTION

Strontium titanate (SrTiO<sub>3</sub>, STO) has a cubic ABO<sub>3</sub> perovskite structure (space group:  $Pm\bar{3}m$ , a lattice constant of  $a = 3.905 \text{ \AA}$ ) at room temperature (RT). It is a nonmagnetic band insulator with an indirect bandgap of 3.25 eV separating the valence band O  $2p$  states and the lowest unoccupied Ti  $3d t_{2g}$  states of the conduction band.<sup>1,2</sup> STO has a large dielectric constant of about 300 at room temperature in a low electric field and exhibits a quantum paraelectric behavior at very low temperatures, i.e., a

suppression (in the ~20–100 K range) of the ferroelectric transition by quantum fluctuations.<sup>2,3</sup> The electrically insulating phases of STO can be made conductive (i) by replacing oxygen atoms with oxygen vacancies, which then act as donor-type dopants or (ii) by subtle chemical doping, e.g., Nb (0.1%)-doped STO. Both undoped and Nb-doped STO single crystals have been widely used as substrates for the growth of oxide films. STO-based structures have shown a rich diversity of remarkable properties including low-temperature high ( $\sim 10^4 \text{ cm}^2\text{V}^{-1}\text{s}^{-1}$ ) electron mobility,<sup>4–6</sup> superconductivity below 300–500 mK,<sup>7,8</sup> room-temperature ferroelectricity,<sup>9,10</sup> large

dielectric constants ( $\epsilon_r \sim 10^3$  at RT),<sup>9,11</sup> room-temperature ferromagnetism,<sup>12</sup> and nonvolatile resistive switching.<sup>13</sup> These interesting properties of STO can be obtained through delicate control of the electron doping (via chemical dopants such as La or Nb), variations in the stoichiometry, strain-induced symmetry breaking, and defect engineering. As a result of this panoply of material properties, for more than half a century, engineered perovskite STO materials and STO-based homo-/heterostructures have attracted considerable scientific interest and become integral materials for oxide-based electronic device applications.

In particular, inducing magnetism in STO thin films can be accomplished through modifications to the lattice strain by employing lattice-mismatched single crystalline oxide substrates (e.g., biaxial strain =  $-1.16\%$  and  $+1.29\%$  for NdGaO<sub>3</sub> and TbScO<sub>3</sub>, respectively) and/or by controlling cation stoichiometry (Sr or Ti deficiency) and oxygen vacancy ( $V_O$ ) concentrations.<sup>14–18</sup> Defects typically result in lattice expansion and a charge rearrangement in STO. This can lead to lattice symmetry breaking (electric polarization), followed by an electronic reconstruction and crystal field splitting (e.g., splitting of degenerate Ti  $3d_{z^2, e_g}$  orbitals into a relative energy scheme that follows  $d_{xz}/d_{yz} < d_{xy} < d_{3z^2-r^2} < d_{x^2-y^2}$ ).<sup>19,20</sup> The origin of magnetism in STO has remained a long-standing problem, and the presence of  $V_O$  defects has been widely regarded as one of the main contributors to magnetization: Oxygen vacancies allow the partial reduction of  $Ti^{4+}$  into magnetically active  $Ti^{3+}$ . A few examples of some of the proposed mechanisms are listed here: Coey *et al.* suggested that the origin of ferromagnetism in reduced STO is either due to direct exchange interactions between  $V_O$  and the molecular orbitals of valence electrons of surrounding Ti ions or due to a Stoner-type spin-splitting of the Ti  $3d$  band for ferromagnetically coupled electrons.<sup>12</sup> However, Brovko and Tosatti<sup>21</sup> reported theoretical results suggesting that an isolated  $V_O$  defect in STO only stabilizes states with low or zero total magnetization since the two Ti spins facing each other across the  $V_O$  are antiferromagnetically coupled via strong direct exchange interaction. Doenning and Pentcheva<sup>22</sup> demonstrated that in LaAlO<sub>3</sub> (LAO)/STO heterostructures, Ti  $d_{xy}$  bands could be dominantly magnetized via magnetic double-exchange interactions between  $Ti^{3+}$  and  $Ti^{4+}$  when a tensile in-plane strain is induced in TiO<sub>6</sub> octahedra and the electron doping level is below  $7 \times 10^{14}$  cm<sup>-2</sup>. However, this electron doping level (0.5e per Ti) per STO monolayer is hard to achieve practically when considering that Ti  $d_{xy}$  orbital polarization in a  $c$ -axis compressed STO is purely induced by a high  $V_O$  concentration of  $\sim 25$  at. % as a  $V_O$  sublattice. Note that it was found that the perovskite lattice of SrTiO<sub>3-x</sub> retains a  $V_O$  concentration of  $\leq 5.6$  at. %.<sup>23</sup> Similar  $V_O$ -mediated Ti magnetization levels have been observed experimentally in reduced STO ceramics,<sup>12,24</sup> STO thin films,<sup>25</sup> STO-based heterostructures (e.g., LAO/STO interfaces),<sup>26</sup> and reduced TiO<sub>2-x</sub>.<sup>27</sup> However, these examples show very weak magnetic responses, which do not appear robust enough to be employed practically. Importantly, it was also found that in the absence of  $V_O$  defects, magnetism can still occur in these systems by controlling cation off-stoichiometry (e.g. Ti vacancies).<sup>28–30</sup> The above observations indicate that magnetism in the STO system might be induced by contributions of both cation and anion defects. Hence, understanding the role of these defects is of critical importance for creating and controlling the associated magnetism in STO.

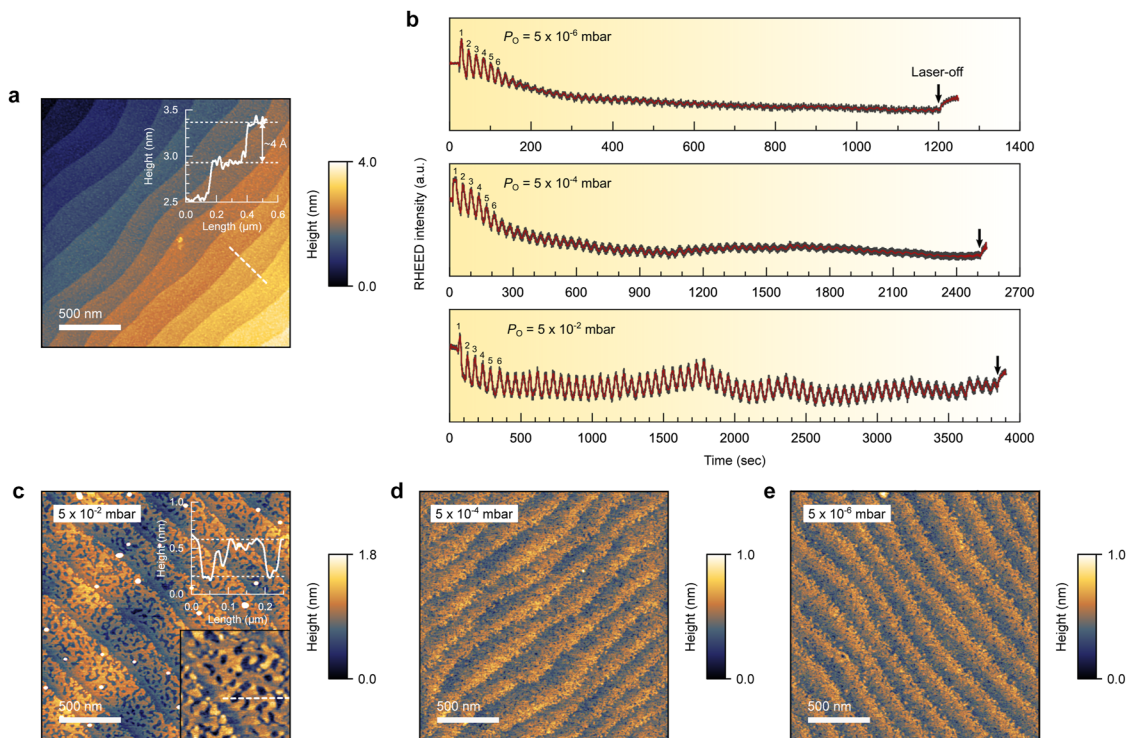
In this work, we demonstrate tunable magnetic properties of homoepitaxial STO thin films by controlling both cation off-stoichiometry ( $V_{Ti}$ ) and  $V_O$  contents using pulsed laser deposition (PLD). Our results show that oxygen partial pressure ( $P_O$ ) strongly influences the growth dynamics and the magnetization of the films. We found incorporating both  $V_{Ti}$  and  $V_O$  defects into the lattice structure can enhance magnetism up to a threshold concentration at which a strong charge compensation occurs. We have used first-principles calculations to classify the effects of individual defects and complex defect pairs on the development of a magnetic response in STO, conclusions which are supported by x-ray magnetic circular dichroism (XMCD) measurements. Our results show that manipulating the oppositely charged atomic defects in STO is the key to creating and tuning magnetism in STO thin films.

## RESULTS AND DISCUSSION

Epitaxial STO films were grown on TiO<sub>2</sub>-terminated STO(001) substrates [Fig. 1(a)] using a pulsed laser deposition (PLD) system equipped with reflection high-energy electron diffraction (RHEED), which was used to control the thickness of the deposited films. The substrate temperature was kept at 700 °C and a laser repetition rate of 1 Hz was employed for the film growth. The laser-beam spot size on the STO target was  $\sim 4.5$  mm<sup>2</sup>. To obtain the growth of B-site cation deficient STO films, we employed a consistent low laser fluence (e.g.,  $\sim 0.6$  J/cm<sup>2</sup>) during film growth, based on our previous work.<sup>29</sup> Meanwhile, the background oxygen partial pressure was varied from  $P_O = 5 \times 10^{-2}$  mbar to  $5 \times 10^{-6}$  mbar. In addition, in order to examine the effect of  $V_O$  concentration on the magnetism of the films, we used different cooling processes after film growth: (i) in a high oxygen atmosphere (200 mbar O<sub>2</sub>) or (ii) in the same atmosphere that was used during film growth.

In PLD, laser fluence strongly influences the kinetic energy of the ablated species, which, in turn, affects the adatom mobility at the substrate surface, thereby also affecting the ablation rate and film thickness.<sup>31</sup> Especially, when considering the growth of complex compound materials, an inadequate fluence can preferentially ablate certain elements over others, which results in the formation of cation nonstoichiometric films.<sup>29–33</sup> It should be noted that preferential ablation happens above a threshold ablation rate. Due to its impact on the ablation rates of various elements, laser fluence has been used in literature to control the stoichiometry of STO films.<sup>29,32,33</sup> In the case of STO, a preferential ablation of Ti (Sr) can be induced by increasing (decreasing) laser fluence, leading to the formation of Sr-(Ti-) deficient STO films. Since the kinetic energy of the arriving species is affected also by the background pressure in the chamber,  $P_O$ , during the PLD process, a suitable balance between the laser fluence and background gas is essential.<sup>31,34</sup> Thus, controlling the relation between the laser fluence and  $P_O$  is an effective way to induce and control atomic defects in the films.

Figure 1(b) shows RHEED intensity oscillations for STO film growth at different  $P_O$ :  $5 \times 10^{-2}$  mbar,  $5 \times 10^{-4}$  mbar, and  $5 \times 10^{-6}$  mbar. The overall thickness of the films was kept around 25–26 nm. The appearance of persistent RHEED oscillations indicates that the growth of STO films occurred in layer-by-layer growth mode. However, it was found that the RHEED intensity dampened faster when  $P_O$  was decreased.  $P_O$  influences the growth rate (pulses

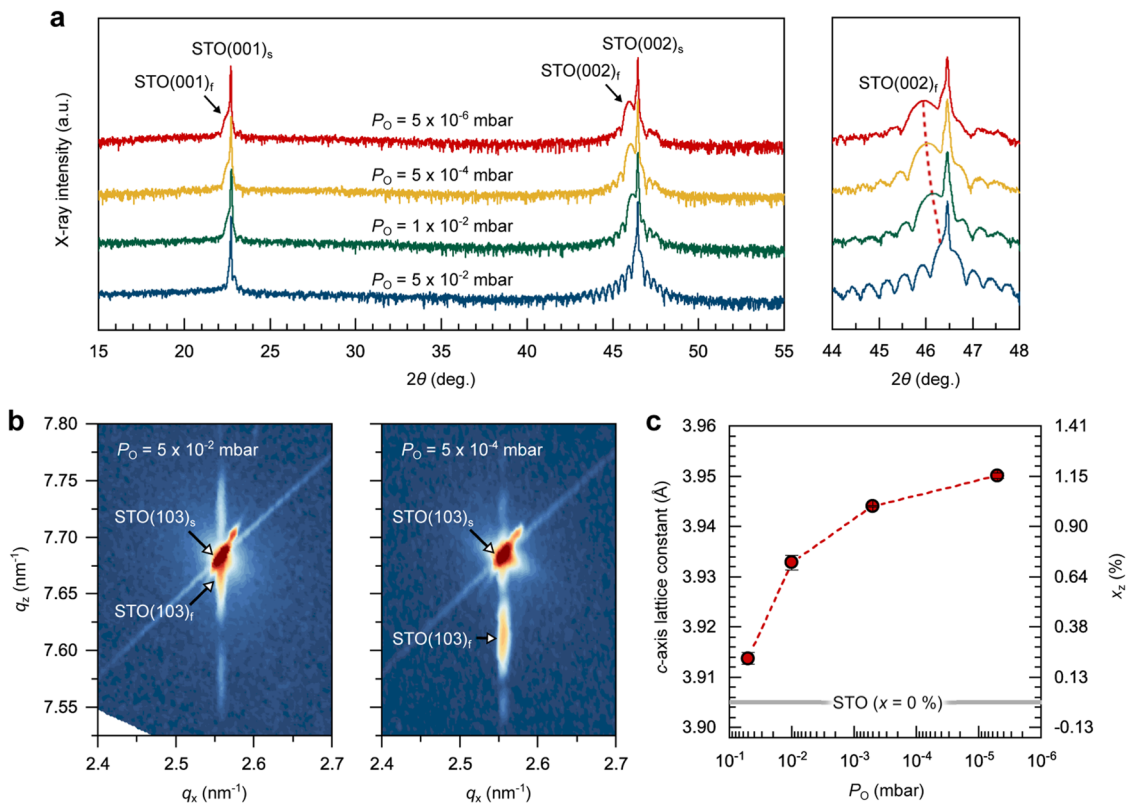


**FIG. 1.** (a) A topography AFM image ( $3 \times 3 \mu\text{m}^2$ ) of atomically terminated  $\text{TiO}_2$ -terminated STO(001) substrate, used for this work. (b) RHEED intensity oscillations for the layer-by-layer STO film growth with different  $P_{\text{O}}$ . [(c)–(e)] Topography AFM images ( $3 \times 3 \mu\text{m}^2$ ) for the grown films in  $P_{\text{O}} = 5 \times 10^{-2}$  mbar (c),  $5 \times 10^{-4}$  mbar (d), and  $5 \times 10^{-6}$  mbar (e). The insets in (c) show a height profile for an incomplete STO monolayer at the step-terrace surface.

needed per unit cell, pls/uc) of the films, which for our experiments was found to be  $\sim 57$  pls/uc at  $5 \times 10^{-2}$  mbar,  $\sim 37$  pls/uc at  $5 \times 10^{-4}$  mbar, and  $\sim 18$  pls/uc at  $5 \times 10^{-6}$  mbar. This  $P_{\text{O}}$ -dependent growth rate variation can be attributed to the change of plasma plume dynamics during film growth, i.e., the higher the  $P_{\text{O}}$ , the more confined the plume expansion. In addition, the stoichiometric composition was found to scale with background  $P_{\text{O}}$ .<sup>34</sup> When the background pressure is high, transport occurs in a diffusion-like regime and Ti and Sr atoms can be fully oxidized in the plasma plume. In contrast, under low background pressures, the interactions between the ablated species and the background gas in the plume are minor and the species in the plume have high kinetic energies and travel following ballistic-like motion. It is particularly in this low pressure regime where preferential elemental ablation can be effectively driven by applying an inadequate laser fluence, thus intentionally controlling the cation off-stoichiometry of STO thin films. This is due to relatively large weight ratios of Ti/Sr (0.56), compared to that of  $\text{TiO}_2/\text{SrO}$  (0.77).<sup>34</sup> At low  $P_{\text{O}}$  values, around  $5 \times 10^{-6}$  mbar, cation off-stoichiometry is observed in the rapid damping of the RHEED intensity during the STO film growth [Fig. 1(b)]. The film variation as a function of  $P_{\text{O}}$  is reflected also in the surface morphology of the grown films as shown in Figs. 1(c)–1(e). For  $P_{\text{O}} = 5 \times 10^{-2}$ , an atomically flat morphology was found with a terrace step height of  $\sim 4$  Å [Fig. 1(c)], similar to the vicinal step-structure of the  $\text{TiO}_2$ -terminated STO surface. Note

that the atomic force microscopy (AFM) image [Fig. 1(c)] shows an incomplete STO monolayer at the step-terrace surface—the height difference within the terrace is around 4 Å. In contrast, at  $P_{\text{O}} \leq 5 \times 10^{-4}$ , the film surface is faceted due to the ballistic motion of the arriving species to the substrates. These results provide a solid indication that the growth dynamics and chemical plasma composition of the STO films can be effectively tuned by  $P_{\text{O}}$ , while the laser fluence is kept constant at a low value.

Figure 2(a) shows the high-resolution x-ray diffraction (XRD)  $2\theta$ - $\omega$  patterns of oxidized STO films, grown on STO(001), as a function of  $P_{\text{O}}$ . Note that all of the measured films were cooled down to RT in an  $\text{O}_2$  atmosphere (200 mbar). The XRD spectra show that the oxidized films were grown epitaxially and possess thickness fringes. The STO film grown at  $P_{\text{O}} = 5 \times 10^{-2}$  mbar shows almost identical  $2\theta$  (00l) peak positions to those of the STO homo-substrate with well-defined thickness fringes. This indicates low out-of-plane strain ( $x_z = +0.19\%$ ) in the film and an excellent crystal quality. When  $P_{\text{O}}$  was decreased to  $P_{\text{O}} = 5 \times 10^{-4}$  mbar, a continuous shift of the out-of-plane STO(00l) peaks toward lower  $2\theta$  values was found. This reveals an increase in the  $c$ -axis lattice parameter to a value of  $c = 3.95$  Å ( $x_z = +1.15\%$ ), as shown in Fig. 2(c). To get further information about the strain distribution of the STO films, we performed reciprocal space mappings (RSMs) around the STO103 reflection for the two films (with  $P_{\text{O}} = 5 \times 10^{-2}$  and  $5 \times 10^{-4}$  mbar) [Fig. 2(b)]. The results show that the in-plane lattice spacing for both films is



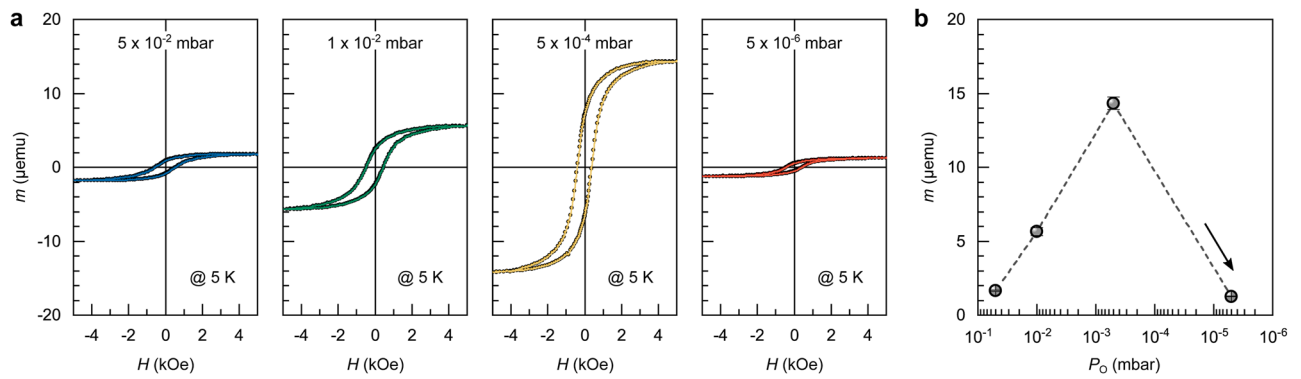
**FIG. 2.** (a) XRD  $2\theta$  scans for the STO films, grown on STO(001) substrates, as a function of  $P_O$ . The right panel shows the XRD (002) peaks for the STO films and substrates. (b) RSM near STO103 reflection for the STO films grown at  $P_O = 5 \times 10^{-2}$  and  $5 \times 10^{-4}$  mbar. (c) Variations in the  $c$ -axis lattice parameter (left) and strain (right) of the films with different  $P_O$ .

coherently aligned with the in-plane spacing of the underlying STO substrates ( $a = 3.905$  Å), while the  $c$ -axis lattice parameter was found to increase with  $P_O$  [Fig. 2(c)].

We investigated the magnetic properties of the oxidized STO films using a superconducting quantum interference device (SQUID) magnetometer. Prior to the sample measurement, external magnetic effects [e.g., sample holders, low-temperature glue, instrumental accessories, and annealed TiO<sub>2</sub>-STO substrates [see Fig. 5(a)]] were carefully eliminated.<sup>29</sup> Figure 3(a) shows the in-plane magnetic hysteresis loops of the STO films, measured at 5 K, as a function of  $P_O$ . The results show a notable increase in the magnetization with decreasing  $P_O$ . The saturation magnetic moment of the films continuously increases up to  $14 \mu\text{emu}$  ( $56 \mu\text{emu}/\text{cm}^2$ ) as the growth pressure is decreased to a value of  $P_O = 5 \times 10^{-4}$  mbar. The enhanced magnetism at low  $P_O$  can be understood through the rise of cation off-stoichiometry (Ti deficiency) in the films. We can rule out that the increase in magnetization results from external magnetic impurities that may have been present in the target materials or in the PLD growth chamber since our results show the opposite trend from what would be expected if this was the case. Lower  $P_O$  values (up to  $5 \times 10^{-4}$  mbar) yield higher film growth rates and, thus, require a shorter total film growth time (decreasing the time that the films are exposed to external impurities) [Fig. 1(b)]; nonetheless,

they produce larger magnetic moments. Another important observation is the steep magnetic degradation ( $\leq 10 \mu\text{emu}$ ) seen in the STO film grown at  $P_O = 5 \times 10^{-6}$  mbar. To confirm this, we repeated the film growth with the same growth conditions and observed the same weak magnetic response as compared to the results obtained using  $P_O = 5 \times 10^{-4}$  mbar. We postulate that this magnetic degradation could be associated with a strong charge compensation between positively and negatively charged  $V_O$  and  $V_{Ti}$  defects as the oxidized film sample, grown at  $P_O = 5 \times 10^{-6}$  mbar, shows a pale gray color. Further oxidation (200 mbar O<sub>2</sub> annealing at 500 °C for 2 h) will eventually cause the formation of a secondary phase (see the supplementary material, Fig. S1).

To understand atomic charge defect-mediated magnetism in STO, we performed first-principles calculations on STO with atomic vacancy defects. Density functional theory (DFT) simulations using VASP code<sup>35</sup> were performed to calculate the electronic, structural, and magnetic properties of ABO<sub>3</sub>-perovskite STO by incorporating all possible atomic vacancy defects ( $V_{Ti}$ ,  $V_{Sr}$ , and  $V_O$ ). The structural relaxation simulation was performed using a  $4 \times 4 \times 4$   $\mathbf{k}$ -mesh and the conjugate-gradient algorithm until the Hellmann-Feynman forces became less than  $5 \times 10^{-3}$  eV/Å. The density of states (DOS) was then obtained using the  $\Gamma$ -centered and compacted  $\mathbf{k}$ -mesh with minor smearing of 10 meV. The

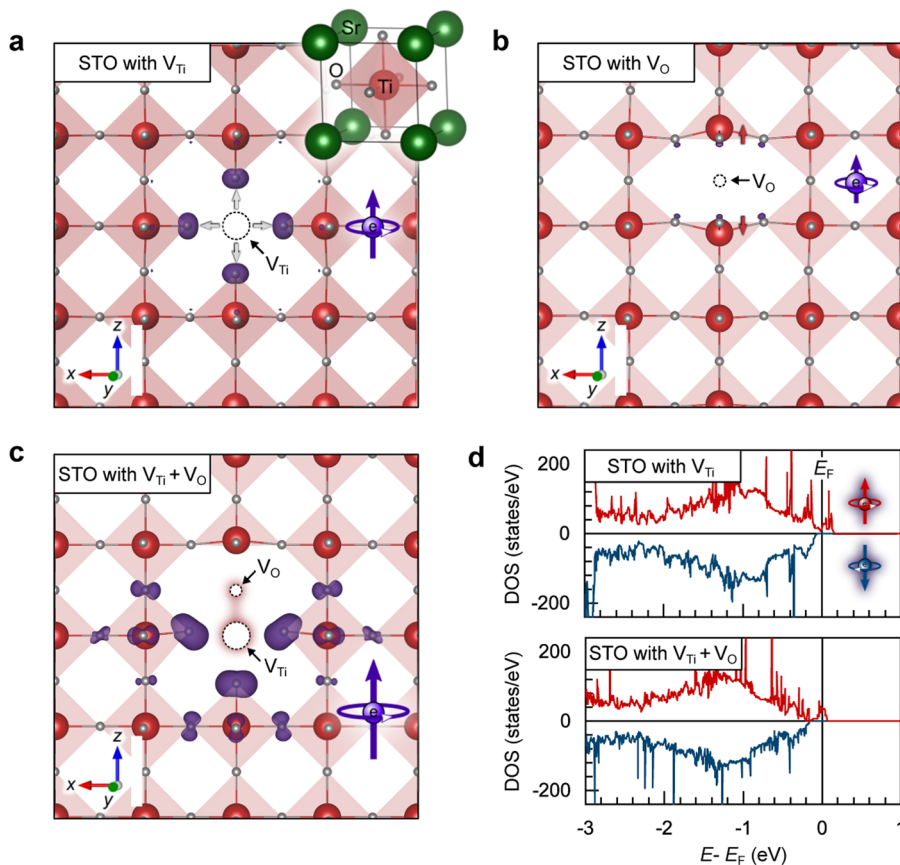


**FIG. 3.** (a) The 5 K magnetic hysteresis loops of the STO films, grown at different  $P_{\text{O}}$  ( $=5 \times 10^{-2}$ ,  $1 \times 10^{-2}$ ,  $5 \times 10^{-4}$ , and  $5 \times 10^{-6}$  mbar). (b) Variations in the magnetic moment of the films as a function of  $P_{\text{O}}$ .

Perdew–Burke–Ernzerhof (PBE) generalized-gradient approximation (GGA)<sup>36</sup> was applied to the exchange-correlation potential. The use of GGA-PBE and its reliability were discussed previously for simulations of the STO structures. Detailed calculation methods are presented elsewhere.<sup>29,37</sup>

Figure 4(a) illustrates a STO model structure with a Ti vacancy ( $V_{\text{Ti}}$ ) defect ( $\sim 2$  at. %) separated by a regular distance of  $4a$  (where

$a$  is the lattice constant). Together with the atomic rearrangement (which produces a local lattice expansion of  $\sim 1.1\%$ ) of the six oxygen neighbors surrounding the  $V_{\text{Ti}}$ , a visible magnetic response in the model structure was found: The O and Ti ions neighboring a  $V_{\text{Ti}}$  site became spin-polarized through charge rearrangement, yielding a  $\mu_{\text{B}}/V_{\text{Ti}}$  of 0.48. It should be noted that the  $V_{\text{Ti}}$  site itself has no magnetic moment. The cation vacancy-induced magnetic moments



**FIG. 4.** [(a)–(c)] Magnetization density of the  $\text{ABO}_3$ -perovskite STO structures, induced by different atomic vacant defects, a  $V_{\text{Ti}}$  (a), a  $V_{\text{O}}$  (b), and a  $V_{\text{Ti}}-V_{\text{O}}$  pair (c). (d) Spin-polarized density of states of the STO with a  $V_{\text{Ti}}$  (upper panel) and with a  $V_{\text{Ti}}-V_{\text{O}}$  pair (lower panel).

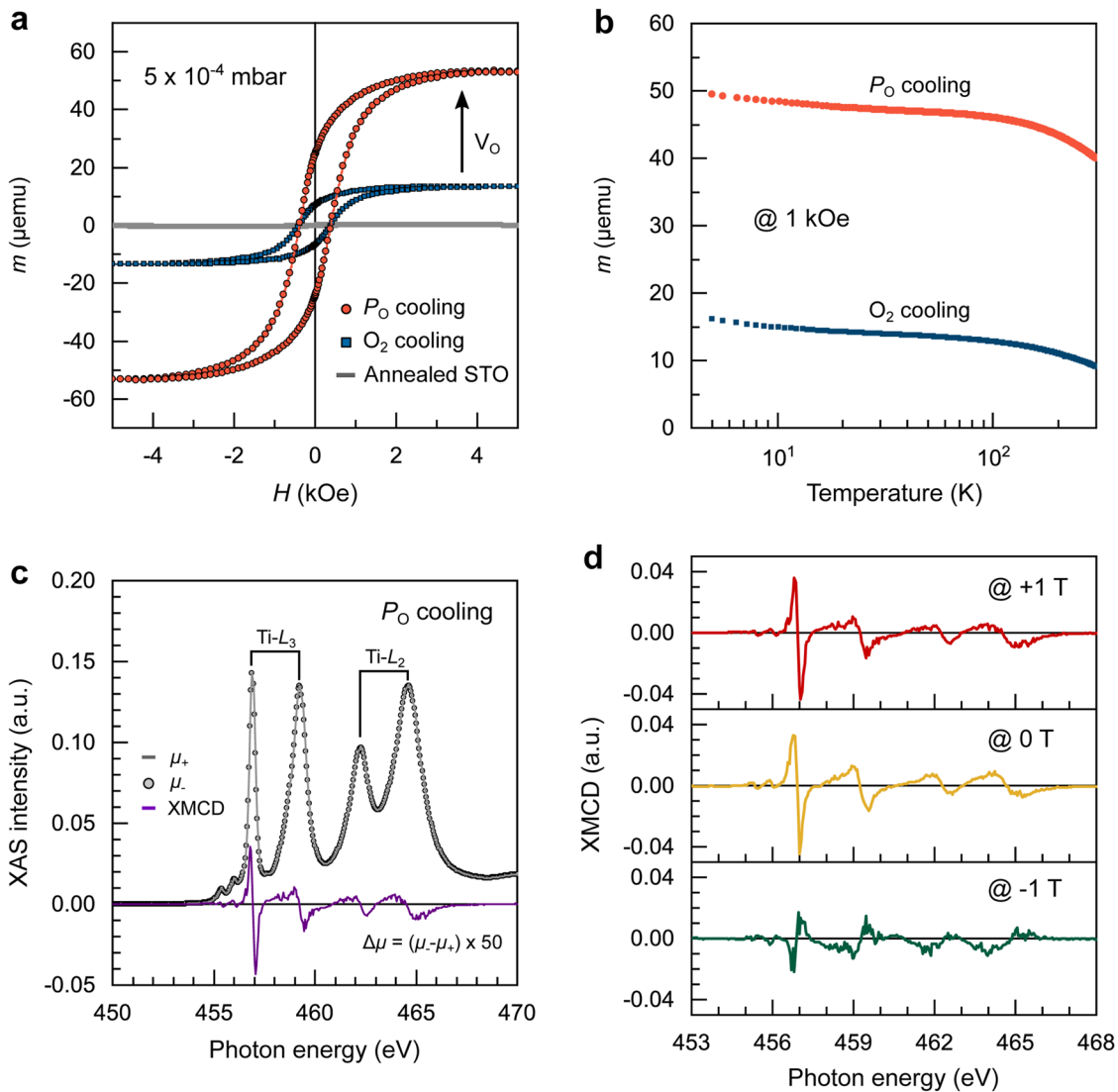
show a dome-shaped dispersive magnetic nature over the surrounding lattices, mostly on the nearest oxygen atoms. The calculated spin-polarized density of states (DOS) of the system further indicates that the negatively charged  $V_{Ti}$  in STO behaves as a  $p$ -type like acceptor locally and leads to the effective spin-polarization of the six nearest oxygen atoms due to unsaturated valence electrons, O  $2p$  electrons (about 70% of the induced magnetization). In this case, a relatively weak Ti magnetization occurs via spin-polarized charge transfer through a  $p$ - $d$  band hybridization. Furthermore, we considered the effect of A-site Sr ( $2+$ ) vacancies on the magnetism of STO. An A-site vacancy defect contributes to a relatively weak magnetization of  $m < 0.07 \mu_B/V_{Sr}$  in STO due to its much less effective charge rearrangement:<sup>29</sup> (i) Only two electrons can contribute to the oxygen atoms adjacent to a Sr vacancy site and (ii) a Sr vacant site has a relatively large distance (2.76 Å) to the 12 nearest oxygens as compared to that (1.95 Å) of a Ti vacant site. In a STO model structure with  $V_O$  defects (~1 at. %), separated by a  $4a$  distance [Fig. 4(b)], the positively charged  $V_O$  acts like an  $n$ -type donor in the system and the local lattice expansion occurs primarily by moving the two neighboring Ti atoms upward. Our calculations show that an isolated  $V_O$  when stabilized in STO produces a very weak magnetism ( $0.003 \mu_B/V_O$ ) without significant exchange interaction with the neighboring Ti atoms (e.g., a magnetization of Ti  $d_{xy}$  bands). This is consistent with previous reports.<sup>21</sup> When the  $V_O$  concentration increases up to ~8 at. %, the defects are placed in STO with a separating distance of  $\sqrt{2}a$  (in an orthorhombic  $\sqrt{2} \times \sqrt{2} \times 2$  supercell) and the Ti  $d_{xy}$  bands become magnetized with a total moment of  $0.41 \mu_B/V_O$ . However, such a defect sublattice in STO with high  $V_O$  concentration is highly unrealistic as an artificial magnetic array since it is hard to retain an  $ABO_3$ -perovskite structure practically.<sup>17</sup>

Next, we examined a STO model structure incorporating both cation and anion vacancy defects. Our results show that a  $V_O$  defect energetically tends to be paired with a  $V_{Ti}$  in STO after relaxation [Fig. 4(c)]. The results of the model indicate that the atomic configuration in which the vacancies are  $1/2a$  apart is much more energetically favorable than pairing at a distance of  $3/2a$  by an energetic difference of ~1 eV. We found that in an unrelaxed model structure, the complex defect pair creates a magnetic spin-moment of  $2 \mu_B$ /pair in the system due to an incomplete charge compensation and the relaxation of the oppositely charged  $V_{Ti}$  ( $4+$ ) and  $V_O$  ( $2-$ ) vacancies. After atomic relaxation with charge screening, the system has a total magnetization of  $0.7 \mu_B$ /pair. The calculated DOS clearly shows a spin-polarized moment distribution near the Fermi level of the system [Fig. 4(d)]. Interestingly, the magnetization of STO induced by the defect pair is higher than the moments for individual cation defects, despite the fact that the defect charge state of  $V_{Ti}$  ( $4+$ ) is higher than that of  $V_{Ti}-V_O$  ( $2+$ ). Our calculations clarify that the large measured magnetization is produced by the  $V_{Ti}-V_O$  pair due to (i) a more energetically stable formation (smaller charge screening effect) in the STO system with a tendency of pairing the oppositely charged defects [when comparing the charge screening effect of STO with a singular  $V_{Ti}$  through relaxation and the largely varied magnetization ( $4 \mu_B/V_{Ti} \rightarrow 0.48 \mu_B/V_{Ti}$ )], (ii) a higher dispersive nature of the induced magnetic moment over the lattice atoms, and (iii) an effective magnetic coupling with a shorter distance ( $3.5a$ ) between the vacant defect pairs. However, it should be noted

that an excessive concentration of  $V_O$  defects in the system can compensate for the charge state of the defect pair. This mechanism could produce a significant degradation in the defect-induced magnetism of STO as can be seen in our experimental results [Fig. 3(b)].

To examine the effect of the  $V_{Ti}-V_O$  defect pair on the magnetism of STO, we prepared B-site cation deficient STO films with different  $V_O$  concentrations. To achieve this, different cooling processes were applied after film growth, i.e., cooling to room temperature in a high  $O_2$  atmosphere (200 mbar) and under the same  $P_O$  as used during growth. Figure 5(a) shows the magnetic hysteresis loops of the STO films measured at 5 K. These two samples were grown using the same laser fluence of ~0.6 J/cm<sup>2</sup> at a pressure of  $P_O = 5 \times 10^{-4}$  mbar, using the two cooling procedures described above. Notably, the magnetic moment of the STO film cooled down in the same  $P_O$  increases by a factor of ~3.5 when compared to that of the film cooled in  $O_2$  atmosphere. This magnetic enhancement is indicative of an increase in the formation of  $V_{Ti}-V_O$  defect pairs in STO driven by the  $P_O$  cooling process. Furthermore, to examine magnetic effects of a reduced STO substrate and possible impurities in the PLD chamber, we annealed a  $TiO_2$ -terminated STO substrate by using the same heating rate (to 700 °C) and  $P_O$  cooling process in the PLD vacuum chamber that was used for film growth. The annealed STO substrate shows no magnetic response [Fig. 5(a)], confirming that the  $P_O$  cooling process at  $5 \times 10^{-4}$  mbar ( $V_O$ ) cannot solely create the observed magnetism of the B-site cation deficient STO films. These results indicate either that the employed  $P_O$  does not create a sufficient number of  $V_O$  sites for achieving ferromagnetic ordering in STO or that the number of  $V_O$  sites plays a minor role in creating the magnetism. Moreover, both B-site cation deficient films show a similar temperature-independent magnetic response in the range of 5–300 K. Such temperature-independent magnetizations for materials with high Curie temperatures of  $\gg 300$  K were also attributed to defect-induced magnetism (e.g., ZnO, MgO,  $TiO_2$ , and  $HfO_2$ ).<sup>12,28,30,38</sup> These are most likely explained by a spin-splitting of the defect-related impurity bands near the conduction band/valence band edge of the systems, as these are the source for ferromagnetically coupled electrons.<sup>12</sup> Our experimental results confirm that the magnetism of STO can be controlled by incorporating both  $V_{Ti}$  and  $V_O$  defects, which probably promotes the formation of  $V_{Ti}-V_O$  pairs. However, the replacement of B-site cation with  $V_O$  defects in STO should be limited (by using  $P_O \sim 5 \times 10^{-4}$  mbar in our case) in order to obtain such a magnetic enhancement and to prevent a strong atomic charge compensation, e.g.,  $1V_{Ti} (4+) + 2V_O (2-)$ .

We further verified the magnetic nature of the B-site cation deficient STO film by x-ray magnetic circular dichroism (XMCD). The Ti  $L_{2,3}$ -edge x-ray absorption (XAS) spectra were collected by using circular polarized light with parallel ( $\mu_+$ ) and antiparallel ( $\mu_-$ ) photon spin while applying a constant magnetic field of +1 T perpendicular to the sample surface, with the probing depth being around 4 nm. The spectra were collected with the beam in normal incidence. The total electron yield method was used to record the spectra (by measuring the sample drain current) in a chamber with a vacuum base pressure of  $2 \times 10^{-10}$  mbar. Figure 5(c) shows the Ti  $L_{2,3}$ -edge XAS and XMCD spectra of the B-site cation deficient STO film sample that was cooled down to RT at the



**FIG. 5.** (a) Comparison of the 5 K magnetic hysteresis loops of the B-site cation deficient STO films, grown at  $P_O = 5 \times 10^{-4}$  mbar, with different cooling processes, i.e., after film growth, the two samples were cooled in a high  $O_2$  atmosphere (blue circle,  $O_2$  cooling) and in the same growth pressure (red circle,  $P_O$  cooling) separately. The hysteretic magnetic responses of the two STO/STO samples are compared with a non-magnetic annealed  $TiO_2$ -STO(001) substrate. (b) Variable temperature magnetic moments of the samples, prepared by different cooling processes. A constant magnetic field of 1 kOe was applied to the samples during the temperature measurements. (c) XAS and XMCD across the Ti  $L_{2,3}$ -edges of the B-site cation deficient STO film sample with  $P_O$  cooling as measured at 4 K. (d) Ti  $L_{2,3}$  XMCD of the same STO thin film as measured by sweeping the applied magnetic fields (+1 T  $\rightarrow$  0 T  $\rightarrow$  -1 T).

same  $P_O$  as the deposition pressure. First, we discard the possibility of the magnetic signal being due to the presence of Ti (3+) states since the spectral shape is typical of pure Ti (4+) as reported previously.<sup>39–41</sup> This indicates that the Ti  $L_{2,3}$  XMCD signal probably stems from the excitation between the  $Ti^{4+} 3d^0$  and O  $2p$  orbitals: the  $Ti^{4+} (3d^0)$  ions are related to the magnetic environment sensitivity of the electrons excited to the  $2P^2 3d^1$  state. The increased number of defect pairs in the STO film should enhance the magnetization of

the surrounding Ti atoms. Furthermore, the reversible XMCD signal under applied field inversion confirms the true magnetic nature of the STO films [see Fig. 5(d)]. As a result, the XMCD analysis suggested that the defect-induced magnetism in the engineered STO films is due to the contribution of  $p$ -type like defects that spread magnetic moments over the surrounding ions. The magnetism of the engineered STO films is unlikely to be due to an accumulation of magnetic  $Ti^{3+}$  ions or any associated magnetic order.



## CONCLUSION

In this work, we have demonstrated that the magnetic properties of engineered STO thin films can be effectively tuned by PLD film growth parameters (interdependent parameters of laser fluence and  $P_O$ ) by controlling the concentration of cation vacancies, anion vacancies, and their complex defects. Our results show that B-site cation vacancies,  $V_{Ti}$ , not only contribute to the magnetization of STO but also promote the incorporation of oppositely charged  $V_O$  into the B-site cation deficient STO for the formation of the  $V_{Ti}-V_O$  pairs. This greatly increases the magnetization and stability of the system and has been demonstrated both experimentally and theoretically. We further show that a strong charge compensation between oppositely charged defects significantly reduces the magnetism of STO, suggesting that under these process conditions, oxygen vacancies are not the main magnetic source for the defect-mediated magnetism of STO since we have not detected the presence of magnetic  $Ti^{3+}$ . Therefore, such a design allowing for tunable magnetism in STO films via atomic defect engineering offers important insights into the possible routes for designing magnetic STO films and related oxide heterosystems.

## SUPPLEMENTARY MATERIAL

See the [supplementary material](#) for XRD  $2\theta$  patterns of the as-grown and  $O_2$ -annealed B-site cation deficient STO film samples, grown at  $5 \times 10^{-6}$  mbar (Fig. S1).

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## AUTHOR DECLARATIONS

### Conflict of Interest

The authors have no conflicts to disclose.

### Author Contributions

**A. D. Rata:** Investigation (equal); Writing – review & editing (equal). **I. Mertig:** Investigation (equal); Writing – review & editing (equal). **A. Ernst:** Investigation (equal); Writing – review & editing (equal). **A. M. Ionescu:** Investigation (equal); Writing – review & editing (equal). **K. Dörr:** Investigation (equal); Writing – review & editing (equal). **N. Pryds:** Conceptualization (equal); Funding acquisition (equal); Supervision (equal); Writing – original draft (equal); Writing – review & editing (equal). **D.-S. Park:** Conceptualization (equal); Data curation (equal); Formal

analysis (equal); Funding acquisition (equal); Investigation (equal); Methodology (equal); Project administration (equal); Resources (equal); Supervision (equal); Validation (equal); Visualization (equal); Writing – original draft (equal); Writing – review & editing (equal). **J. Herrero-Martin:** Investigation (equal); Writing – review & editing (equal). **I. V. Maznichenko:** Investigation (equal); Writing – review & editing (equal). **F. M. Chiabrera:** Investigation (equal); Writing – review & editing (equal). **R. T. Dahm:** Investigation (equal); Writing – review & editing (equal). **S. Ostanin:** Investigation (equal); Writing – review & editing (equal). **D. Lee:** Investigation (equal); Writing – review & editing (equal). **B. Jalan:** Investigation (equal); Writing – review & editing (equal). **P. Buczek:** Investigation (equal); Writing – review & editing (equal).

## DATA AVAILABILITY

The data that support the findings of this study are available within the article.

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